**IRF624** 

Vishay Siliconix



**TO-220AB** 

**PRODUCT SUMMARY** 

V<sub>DS</sub> (V)

R<sub>DS(on)</sub> (Ω)

Q<sub>qs</sub> (nC)

Q<sub>gd</sub> (nC)

Q<sub>a</sub> max. (nC)

Configuration

# **Power MOSFET**

## FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

#### Note

S

N-Channel MOSFET

1.1

250

14

2.7

7.8

Single

V<sub>GS</sub> = 10 V

\* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

### DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRF624PbF
Lead (Pb)-free and halogen-free	IRF624PbF-BE3

PARAMETER		SYMBOL	LIMIT	UNIT		
Drain-source voltage		V <sub>DS</sub>	250	- V		
Gate-source voltage			V <sub>GS</sub>			± 20
Continuous drain current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 25 °C	1-	4.4		
Continuous drain current	V <sub>GS</sub> at 10 V	T <sub>C</sub> = 100 °C	I <sub>D</sub>	2.8	A	
Pulsed drain current <sup>a</sup>			I <sub>DM</sub>	14	1	
Linear derating factor				0.40	W/°C	
Single pulse avalanche energy <sup>b</sup>			E <sub>AS</sub>	100	mJ	
Repetitive avalanche current <sup>a</sup>			I <sub>AR</sub>	4.4	А	
Repetitive avalanche energy <sup>a</sup>			E <sub>AR</sub>	5.0	mJ	
Maximum power dissipation	T <sub>C</sub> = 25 °C		PD	50	W	
Peak diode recovery dV/dt <sup>c</sup>			dV/dt	4.8	V/ns	
Operating junction and storage temperature range		T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C		
Soldering recommendations (peak temperature) <sup>d</sup>	d For 10 s		300	U U		
Mounting torque	6-32 or M3 screw			10	lbf ∙ in	
Mounting torque				1.1	N · m	

### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b.  $V_{DD}$  = 50 V, starting T<sub>J</sub> = 25 °C, L = 8.3 mH, R<sub>g</sub> = 25  $\Omega$ , I<sub>AS</sub> = 4.4 A (see fig. 12)

c.  $I_{SD} \le 4.4$  A, dl/dt  $\le 90$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C

d. 1.6 mm from case

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THERMAL RESISTANCE RATI	NGS						
PARAMETER	SYMBOL	TYP.	MAX.			UNIT	
Maximum junction-to-ambient	R <sub>thJA</sub>	-	62				
Case-to-sink, flat, greased surface	R <sub>thCS</sub>	0.50	-			°C/W	
Maximum junction-to-case (drain)	R <sub>thJC</sub>	_	2.5				
	- 1150		2.0		l		
SPECIFICATIONS (T <sub>J</sub> = 25 °C, u	Inless otherw	rise noted)					
PARAMETER	SYMBOL		CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static	1	1		•	1	1	1
Drain-source breakdown voltage	V <sub>DS</sub>	V <sub>GS</sub> =	) V, I <sub>D</sub> = 250 μA	250	-	-	V
V <sub>DS</sub> temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference	to 25 °C, I <sub>D</sub> = 1 mA	-	0.36	-	V/°C
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	/ <sub>GS</sub> , I <sub>D</sub> = 250 μΑ	2.0	-	4.0	V
Gate-source leakage	I <sub>GSS</sub>	Vo	<sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zeve este veltere dus's summert		$V_{DS} = 2$	$V_{DS} = 250 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	25	
Zero gate voltage drain current	IDSS	V <sub>DS</sub> = 200 V,	V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	μA
Drain-source on-state resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 2.6 A <sup>b</sup>	-	-	1.1	Ω
Forward transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 5	0 V, I <sub>D</sub> = 2.6 A <sup>b</sup>	1.5	-	-	S
Dynamic							
Input capacitance	C <sub>iss</sub>	l l	$V_{GS} = 0 V,$	-	260	-	
Output capacitance	C <sub>oss</sub>	V	<sub>DS</sub> = 25 V,	-	77	-	pF
Reverse transfer capacitance	C <sub>rss</sub>	f = 1.0	MHz, see fig. 5	-	15	-	
Total gate charge	Qg			-	-	14	
Gate-source charge	Q <sub>gs</sub>	$V_{GS} = 10 V$	$I_D = 4.4 \text{ A}, V_{DS} = 200 \text{ V},$ see fig. 6 and 13 <sup>b</sup>	-	-	2.7	nC
Gate-drain charge	Q <sub>gd</sub>	]	see lig. o and to	-	-	7.8	
Turn-on delay time	t <sub>d(on)</sub>			-	7.0	-	
Rise time	tr	V <sub>DD</sub> = 1	25 V, I <sub>D</sub> = 4.4 A,	-	13	-	
Turn-off delay time	t <sub>d(off)</sub>	$R_g = 18 \Omega, R_D = 28 \Omega, \text{ see fig. 10 b}$ -		-	20	-	ns
Fall time	t <sub>f</sub>			12	-		
Gate input resistance	Rg	f = 1 N	IHz, open drain	0.7	-	5.4	Ω
Internal drain inductance	L <sub>D</sub>	Between lea 6 mm (0.25")	from	-	4.5	-	
Internal source inductance	L <sub>S</sub>	package and center of die contact		-	- nH		
Drain-Source Body Diode Characteristic	CS	1		1			1
Continuous source-drain diode current	۱ <sub>S</sub>	MOSFET syr showing th		-	-	4.4	_
Pulsed diode forward current <sup>a</sup>	I <sub>SM</sub>	p - n junction diode		-	14	- A	
Body diode voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I	$_{\rm S}$ = 4.4 A, V <sub>GS</sub> = 0 V <sup>b</sup>	-	-	1.8	V
Body diode reverse recovery time	t <sub>rr</sub>	T 25 °C I -	4.4 A, dl/dt = 100 A/µs <sup>b</sup>	-	200	400	ns
Body diode reverse recovery charge	Q <sub>rr</sub>	$I_{J} = 23  O, I_{F} =$	$+.+$ $A$ , $u/u_1 = 100 A/\mu S^{-5}$	-	0.93	1.9	μC
Forward turn-on time	t <sub>on</sub>	Intrinsic turr	I-on time is negligible (turr	n-on is doi	minated b	y L <sub>S</sub> and	L <sub>D</sub> )

### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)

b. Pulse width  $\leq$  300 µs; duty cycle  $\leq$  2 %

2



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## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

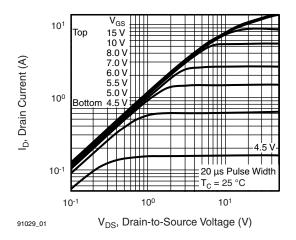


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

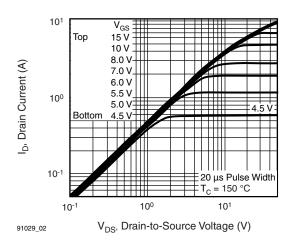
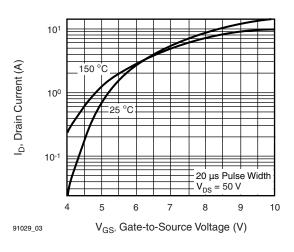


Fig. 2 - Typical Output Characteristics,  $T_C = 150$  °C





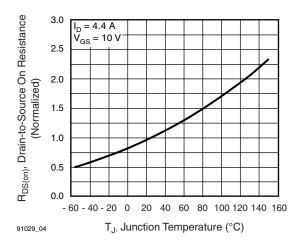


Fig. 4 - Normalized On-Resistance vs. Temperature

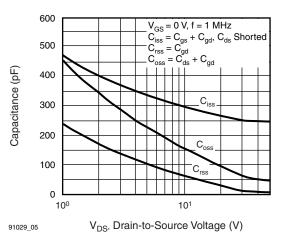
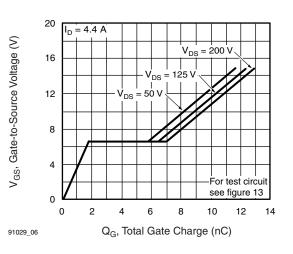
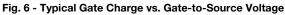


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage





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**3** For technical questions, contact: <u>hvm@vishay.com</u> Document Number: 91029

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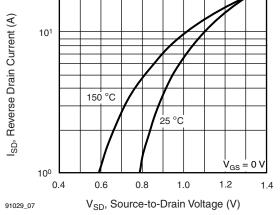


Fig. 7 - Typical Source-Drain Diode Forward Voltage

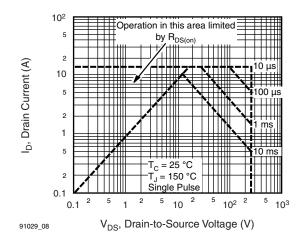


Fig. 8 - Maximum Safe Operating Area

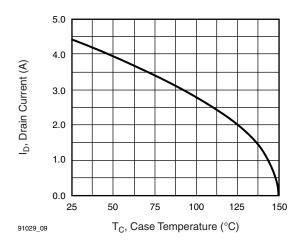


Fig. 9 - Maximum Drain Current vs. Case Temperature

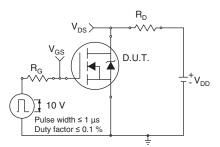


Fig. 10a - Switching Time Test Circuit

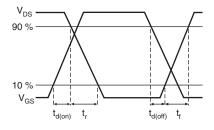


Fig. 10b - Switching Time Waveforms

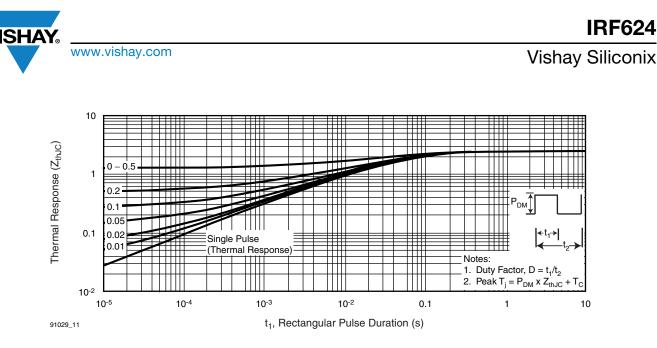


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

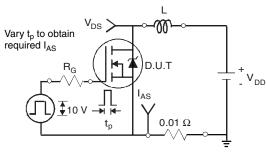


Fig. 12a - Unclamped Inductive Test Circuit

I<sub>AS</sub> \_\_\_\_ ∠\_\_\_\_ └\_\_\_\_\_ Fig. 12b - Unclamped Inductive Waveforms

V<sub>DS</sub>

'DS

 $V_{\text{DD}}$ 

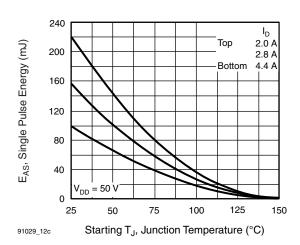
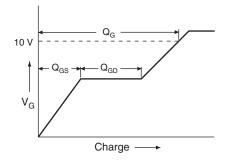


Fig. 12c - Maximum Avalanche Energy vs. Drain Current



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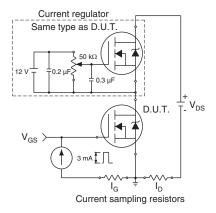


Fig. 13a - Basic Gate Charge Waveform



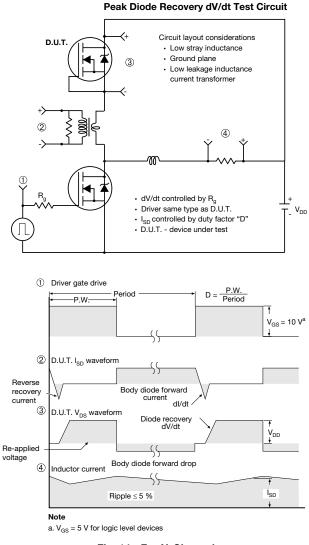


Fig. 14 - For N-Channel

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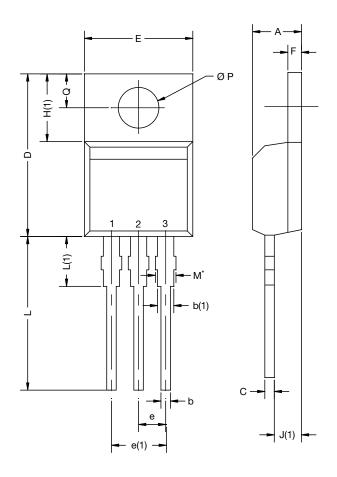
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TO-220-1



DIM.	MILLIN	METERS	INC	HES
MIN.		MAX.	MIN.	MAX.
А	4.24	4.65	0.167	0.183
b	0.69	1.02	0.027	0.040
b(1)	1.14	1.78	0.045	0.070
С	0.36	0.61	0.014	0.024
D	14.33	15.85	0.564	0.624
E	9.96	10.52	0.392	0.414
е	2.41	2.67	0.095	0.105
e(1)	4.88	5.28	0.192	0.208
F	1.14	1.40	0.045	0.055
H(1)	6.10	6.71	0.240	0.264
J(1)	2.41	2.92	0.095	0.115
L	13.36	14.40	0.526	0.567
L(1)	3.33	4.04	0.131	0.159
ØP	3.53	3.94	0.139	0.155
Q	2.54	3.00	0.100	0.118

### Note

• M\* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM

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